













CSD18533KCS

SLPS362C - SEPTEMBER 2012-REVISED JUNE 2015

CSD18533KCS 60 V N-Channel NexFET™ Power MOSFET

Features

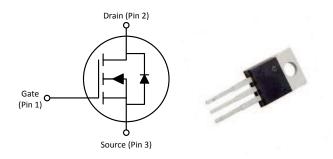
- Ultra-Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Logic Level
- Pb-Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- TO-220 Plastic Package

Applications

- DC-DC Conversion
- Secondary Side Synchronous Rectifier
- Motor Control

3 Description

This 5.0 m Ω , 60 V TO-220 NexFETTM power MOSFET is designed to minimize losses in power conversion applications.



Product Summary

$T_A = 25^\circ$	С	TYPICAL VA	UNIT		
V_{DS}	Drain-to-source voltage 60				
Q_g	Gate charge total (10 V)	28			
Q_{gd}	Gate charge gate-to-drain	3.9	nC		
В	Drain-to-source on-resistance	V _{GS} = 4.5 V	6.9	mΩ	
R _{DS(on)}	Diam-to-source on-resistance	V _{GS} = 10 V 5.0		mΩ	
$V_{GS(th)}$	Threshold voltage	1.9	V		

Ordering Information⁽¹⁾

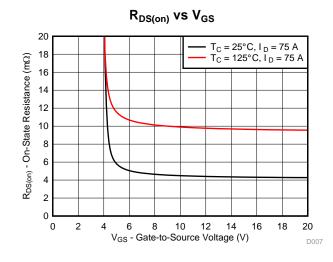
DEVICE	QTY	MEDIA	PACKAGE	SHIP	
CSD18533KCS	50	Tube	TO-220 Plastic Package	Tube	

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

	Absolute Maximum Ratings								
T _A = 2	5°C	VALUE	UNIT						
V_{DS}	Drain-to-source voltage	60	V						
V_{GS}	Gate-to-source voltage	±20	٧						
	Continuous drain current (package limited)	100							
I _D	Continuous drain current (silicon limited), T _C = 25°C	118	Α						
	Continuous drain current (silicon limited), T _C = 100°C	84							
I_{DM}	Pulsed drain current (1)	294	Α						
P_D	Power dissipation	192	W						
T _J , T _{stg}	Operating junction, Storage temperature	-55 to 175	°C						
E _{AS}	Avalanche energy, single pulse $I_D = 52 \text{ A}, L = 0.1 \text{ mH}, R_G = 25 \Omega$	135	mJ						

(1) Max $R_{\theta JC} = 0.8$ °C/W, pulse duration $\leq 100 \mu s$, duty cycle $\leq 1\%$



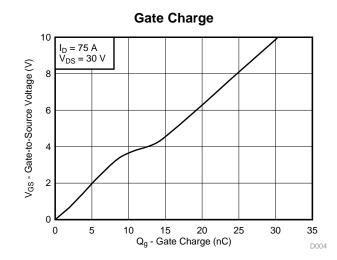




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

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C	nailyes from Revision A (January 2013) to Revision B	гау
•	Updated document title to include part number	
•	Updated part description	········ ·
•	Increased currents to reflect increase in max temperature	······································
•	Increased max power to reflect increase in max temperature	
•	Increased max temperature to 175°C	·
•	Updated Figure 6 to extend to 175°C	!
•	Updated Figure 8 to extend to 175°C	!
•	Updated Figure 12 to extend to 175°C	

C	hanges from Original (September 2012) to Revision A	Page
•	Changed Q _{q(th)} , Gate Charge at V _{th} value From: 7.3 To: 4.6	3

Product Folder Links: CSD18533KCS

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5 Specifications

5.1 Electrical Characteristics

 $(T_{\Delta} = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _D = 250 μA	60			V
I _{DSS}	Drain-to-source leakage current	$V_{GS} = 0 \text{ V}, V_{DS} = 48 \text{ V}$			1	μΑ
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.5	1.9	2.3	V
В	Drain-to-source on-resistance	$V_{GS} = 4.5 \text{ V}, I_D = 75 \text{ A}$		6.9	9.0	mΩ
R _{DS(on)}	Drain-to-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 75 \text{ A}$		5.0	6.3	mΩ
9 _{fs}	Transconductance	V _{DS} = 30 V, I _D = 75 A		150		S
DYNAMI	C CHARACTERISTICS				,	
C _{iss}	Input capacitance			2420	3025	pF
C _{oss}	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$		300	375	pF
C _{rss}	Reverse transfer capacitance			7	9.1	pF
R_G	Series gate resistance			1.4	2.8	Ω
Qg	Gate charge total (4.5 V)			14	17	nC
Qg	Gate charge total (10 V)			28	34	nC
Q _{gd}	Gate charge gate-to-drain	V _{DS} = 30 V, I _D = 75 A		3.9		nC
Q _{gs}	Gate charge gate-to-source			9.4		nC
Q _{g(th)}	Gate charge at V _{th}			4.6		nC
Q _{oss}	Output charge	V _{DS} = 30 V, V _{GS} = 0 V		31		nC
t _{d(on)}	Turn on delay time			5.7		ns
t _r	Rise time	V _{DS} = 30 V, V _{GS} = 10 V,		4.8		ns
t _{d(off)}	Turn off delay time	$I_{DS} = 75 \text{ A}, R_G = 0 \Omega$		13		ns
t _f	Fall time			3.2		ns
DIODE C	CHARACTERISTICS					
V _{SD}	Diode forward voltage	I _{SD} = 75 A, V _{GS} = 0 V		0.8	1	V
Q _{rr}	Reverse recovery charge	V _{DS} = 30 V, I _F = 75 A,		97		nC
t _{rr}	Reverse recovery time	di/dt = 300 A/µs		49		ns

5.2 Thermal Information

(T_A = 25°C unless otherwise stated)

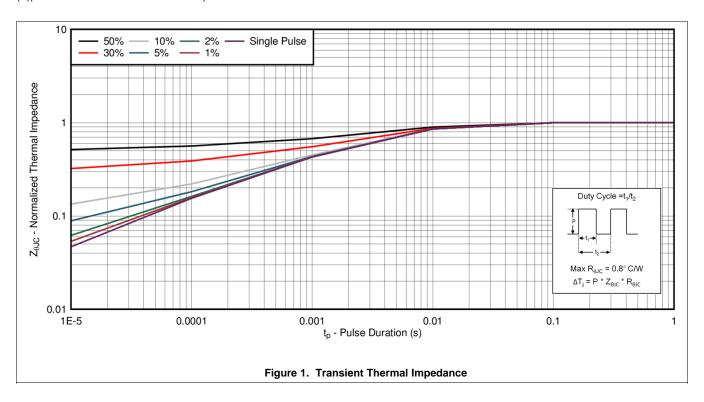
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.8	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance			62	°C/W

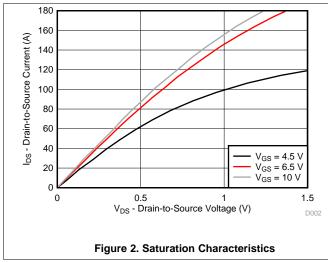
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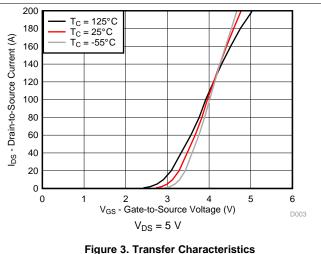


5.3 Typical MOSFET Characteristics

(T_A = 25°C unless otherwise stated)







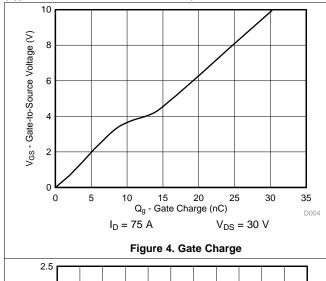
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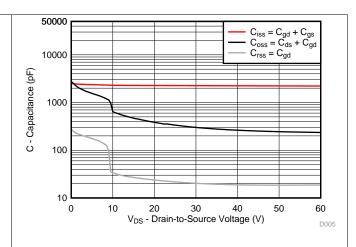
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Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)





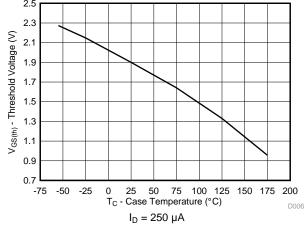


Figure 5. Capacitance

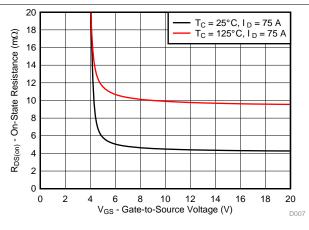


Figure 6. Threshold Voltage vs Temperature

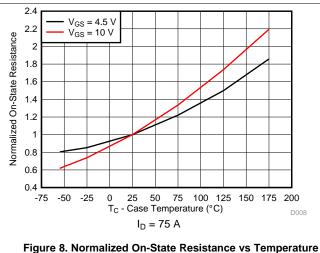


Figure 7. On-State Resistance vs Gate-to-Source Voltage

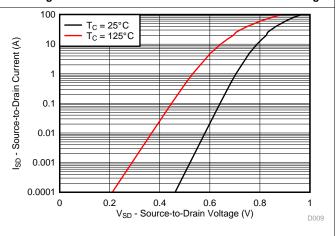
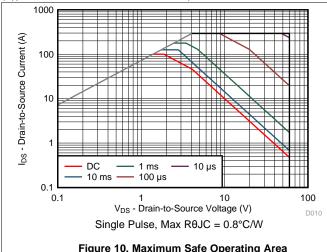


Figure 9. Typical Diode Forward Voltage



Typical MOSFET Characteristics (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



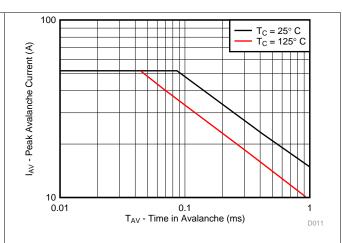


Figure 10. Maximum Safe Operating Area

Figure 11. Single Pulse Unclamped Inductive Switching

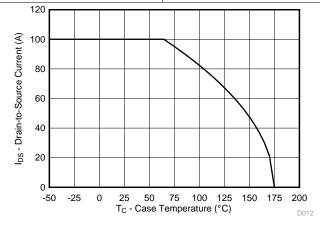


Figure 12. Maximum Drain Current vs Temperature

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6 Device and Documentation Support

6.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

6.2 Trademarks

NexFET, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

6.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

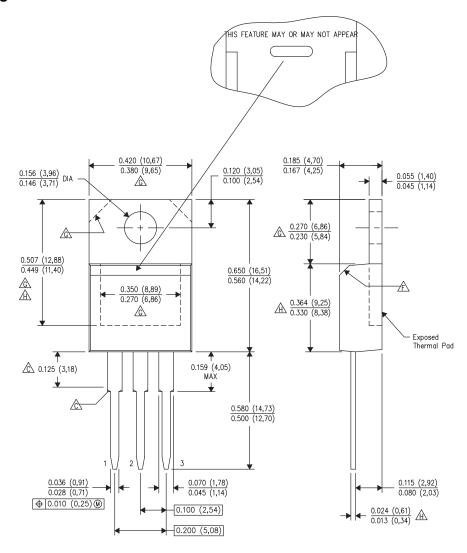
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Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 KCS Package Dimensions



A. All linear dimensions are in inches (millimeters). This drawing is subject to change without notice.

Lead dimensions are not controlled within this area. Chamfer may or may not appear

All lead dimensions apply before solder dip.

The center lead is in electrical contact with the mounting tab.

The chamfer is optional.

Thermal pad contour optional within these dimensions.

A Falls within JEDEC TO-220 variation AB, except minimum lead thickness, minimum exposed pad length,

Pin Configuration

Position	Designation
Pin 1	Gate
Pin 2 / Tab	Drain
Pin 3	Source

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PACKAGE OPTION ADDENDUM

7-Nov-2018

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD18533KCS	ACTIVE	TO-220	KCS	3	50	Pb-Free (RoHS)	CU SN	N / A for Pkg Type	-55 to 175	CSD18533KCS	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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